

1
2
3
4
5
6
7
8
9
10
11
12
13
14
15
16
17
18
19
20
21
22
23

Mode Excitability and Selectivity for Enhancing Scanning Guided Wave-based Characterization of Subwavelength Defect

Kai Wang^{a,b*}, Ruiqi Guan^c, Yaozhong Liao^{a,b}, Zhongqing Su^{a,b}

^a Department of Mechanical Engineering, The Hong Kong Polytechnic University, Kowloon, Hong Kong SAR

^b The Hong Kong Polytechnic University Shenzhen Research Institute, Shenzhen 518057, P.R. China

^c Interdisciplinary Division of Aeronautical and Aviation Engineering, The Hong Kong Polytechnic University, Kowloon, Hong Kong SAR

Submitted to *NDT & E International*

(Initial submission on 26th June 2020; Revised and re-submitted on 10th October 2020)

* To whom correspondence should be addressed. Tel.: +852-6576-4811; Email: kai-qf.wang@polyu.edu.hk (Kai WANG, *PhD*);

24 **Abstract**

25 The scanning guided ultrasonic waves (GUWs) have been exploited intensively for
26 characterization of defects or material anomalies at their early stage. Yet, the
27 characterization of defects in a subwavelength scale, which induces indiscernible
28 disturbance to the linear and nonlinear features of GUWs, remains a daunting task for
29 methods using the scanning GUWs owing to their limitation in terms of sensitivity
30 and applicability. Based on the investigation of effect of defect on the excitability of
31 GUW modes, we establish a framework to distinguish the optimal GUW mode with
32 which the characterization of the small defect with subwavelength size using scanning
33 GUWs can be enhanced. In this framework, the excitation transducer is scanned across
34 the surface of the specimen to generate probing GUWs. The excitability of each GUW
35 mode is analyzed, and the theoretical interpretation of effect of defect on excitation of
36 each GUW mode is interrogated using a reciprocity theorem and Born approximation.
37 In conjunction with the analysis of group velocity of GUW modes, the candidate GUW
38 mode, *i.e.* mode S_1 at a frequency-thickness product of 3.58 MHz·mm, which features
39 an excitability with optimal sensitivity to defect and high practical applicability is
40 selected. A damage index that calibrates the extent of defect-induced variation in the
41 waveform of the selected GUW mode is proposed, with which the subwavelength
42 defects can be characterized accurately and reliably. Both numerical and experimental
43 validations are performed, in which the surface and subsurface defects of
44 subwavelength scales are identified and visualized using an imaging algorithm. The
45 results corroborate the effectiveness of the proposed framework for enhancing the
46 characterization of subwavelength defects using modally selective scanning GUWs.

47
48 **Keywords:** subwavelength defect; guided ultrasonic waves; mode excitability;
49 nondestructive evaluation

50 **1. Introduction**

51 Early detection of defects (e.g. embryonic fatigue cracks, pitting corrosions, small scale
52 voids), which is of great importance for safety-critical structures, entails high sensitivity
53 of nondestructive evaluation approaches. This requirement is of paramount priority to
54 warrant the integrity of components working in harsh environments and subjected to
55 intense loading, in which defects can develop and expand rapidly. Driven by this
56 concern, approaches that utilize transducers, in a contact [1-3] or non-contact manner
57 [4-6], to scan inspected regions are numerous and have been widely applied. Among
58 these approaches, conventional techniques, typified by those using the bulk wave
59 analysis (e.g. C-scan), are confronted with multifold bottlenecks: i) limited
60 effectiveness for structures of small thickness; ii) difficulty in resolving echoes from
61 near-surface defects, particularly for defects of subwavelength size; and iii) challenge
62 in resolving individual plies-induced reflections from the subwavelength defect-
63 induced reflection in composite laminates [7, 8]. These concerns are also stressed for
64 methods using noncontact laser-generated ultrasound, which are prevailing in specific
65 applications requiring noncontact scanning. Therefore, the methods based on the
66 scanning guided ultrasonic waves (GUWs), which can circumvent the above
67 deficiencies, have been attracting intense research efforts. Via analyzing the scanning
68 GUWs, the detection of diverse material anomalies can thereby be fulfilled with high
69 sensitivity, owing to the rich information acquired from each wave excitation/sensing
70 in the scanned region.

71

72 Exploiting the defect-induced disturbance in linear features and nonlinear features of
73 probing GUWs, one can diagnose diverse material anomalies and evaluate the structural

74 health condition qualitatively and quantitatively [9-12]. Nevertheless, the further
75 improvement of the sensitivity of existing methods (linear or nonlinear) are limited by
76 diverse factors related with the intrinsic features of GUWs. Using the features of defect-
77 induced wave scattering that are of the same frequency with the incident waves, the
78 prevailing linear GUW-based methods might overlook the defect with a scale smaller
79 than half the wavelength of probing waves[13, 14], because the wave scattering caused
80 by the defect is small. This deficiency can be tackled to some extent by increasing the
81 incident frequency, but this incurs the difficulty in signal interpretation, owing to the
82 co-existence of multimodal waves and high dispersion and attenuation of GUWs in the
83 high frequency range. To detect small defect that does not induce great wave scattering,
84 methods based on nonlinear features of GUWs, typified by the second harmonic
85 generation[15-19], vibration-acoustic modulation[20, 21] and amplitude modulation
86 phenomenon[22], have been intensively attempted. In previous investigations[15, 16,
87 23], we analyzed the defect-induced nonlinear features of GUWs and proposed methods
88 to exploit them for the quantitative evaluation of small damages in two-dimensional
89 and three dimensional scenarios and orienting the propagation direction of fatigue
90 cracks. Despite the effectiveness of these nonlinear methods in laboratory environments,
91 the practical measurement and calibration of the nonlinear features in probing GUWs
92 remain a challenging task, because of their weak nature and susceptibility to
93 interference induced by other nonlinear sources (e.g. systems and instruments) [24-27].
94 More importantly, material defects of certain types do not induce the material acoustic
95 nonlinearity. For example, the pitting defects and voids in materials generated by
96 manufacturing glitches only cause discontinuities of materials without altering material
97 properties, inducing no nonlinear features in probing waves. Therefore, owing to the
98 limitations in terms of sensitivity for linear methods and practical applicability for

99 nonlinear methods, the characterization of subwavelength defects remains a daunting
100 task.

101
102 The investigation of excitability of GUW modes can potentially offer a novel avenue
103 for the characterization of subwavelength defects, in light of the fact that the excitability
104 of each GUW mode can be disturbed by the defect. Investigations on the excitability of
105 GUW modes, from theoretical and experimental perspectives, are numerous [28-34].
106 In some investigations, the energy enhancement when the laser pulses are in the vicinity
107 of defects is used for the defect detection [35, 36] , and its effectiveness has been further
108 demonstrated in FEA simulations and experiment tests [37-40]. Despite the
109 effectiveness in detection of small scale crack [40], the detection of defects whose
110 dimensions (i.e. length, width, depth) are all subwavelength has rarely been reported.
111 In these investigations, the energy enhancement phenomenon is attributed to the defect-
112 induced reflections, generation of non-propagating modes, mode conversions and wave
113 diffraction. Nevertheless, the aspect of mode excitability has not been scrutinized, and
114 further explicit and quantitative interpretation of defect-altered mode excitability is
115 almost absent. Up to date, investigations dedicated to the analysis of excitability of
116 GUW mode are only conducted in an intact waveguide, and the study and application
117 of effect of defect on the excitation of GUW modes are rare.

118

119 In this backdrop, we develop a method based on the effect of defect on excitability of
120 GUW modes which enhances the sensitivity and practical applicability for the
121 characterization of defects with subwavelength sizes using scanning GUWs. The
122 scanning GUWs are fulfilled using a scanning excitation transducer and a sensor
123 immobilized on the specimen. This method is underpinned by the fact that for certain
124 GUW modes, the defect-induced disturbance in excitability can be obvious at some

125 specific frequency-thickness combinations, thereby rendering a capacity of identifying
126 subwavelength defects. To exploit this effect to advance the evaluation of defects, an
127 analytical interpretation of the influence of defect on the excitability of G UW modes is
128 required, which serves as the theoretical cornerstone.

129

130 Apart from the analytical investigation on the mechanism of G UW excitability under
131 the influence of defect, the selection of G UW mode with high applicability is also of
132 practical significance, considering the multimodal and dispersive properties of G UWs.
133 The selection criteria include the following two aspects. First, the selected mode-
134 frequency combination of G UW features easy separation from other possibly excited
135 modes. Second, the extent of defect-induced variation in the excitability shall be great,
136 featuring an outstanding sensitivity to defects. In addition, the candidate modes in the
137 low frequency range are preferred since they feature relatively less attenuation.

138

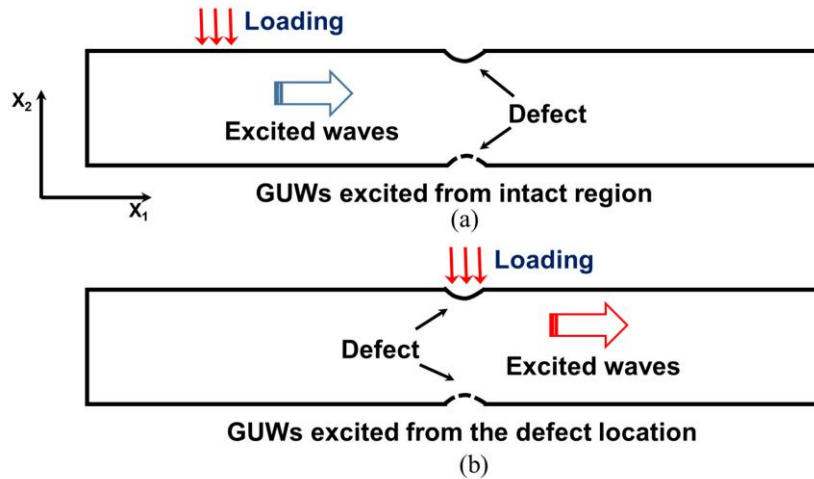
139 Addressing the above concerns, a framework is constructed in this investigation which
140 is capable of selecting specific G UW modes that can significantly advance the G UW-
141 based methods in terms of sensitivity and applicability, and thereby defects of
142 subwavelength size can be identified. In this approach, the excitability of each G UW
143 mode is analytically interpreted, and the defect-altered G UW excitation is investigated
144 using the reciprocity theorem. Meanwhile, to facilitate the separation of selected G UW
145 mode from other excited modes, the examination of group velocity is incorporated in
146 the framework to warrant the isolation of selected G UW mode. Using this framework,
147 the G UW mode with practical feasibility and optimal sensitivity to defects can be
148 selected. On this basis, an index based on the proximity decorrelation is proposed to
149 quantify the defect-induced variations in the waveforms of excited G UWs, with which
150 the severity of the defect can be quantitatively evaluated and intuitively visualized.

151 **2. Analytical Framework for G UW Mode Selection**

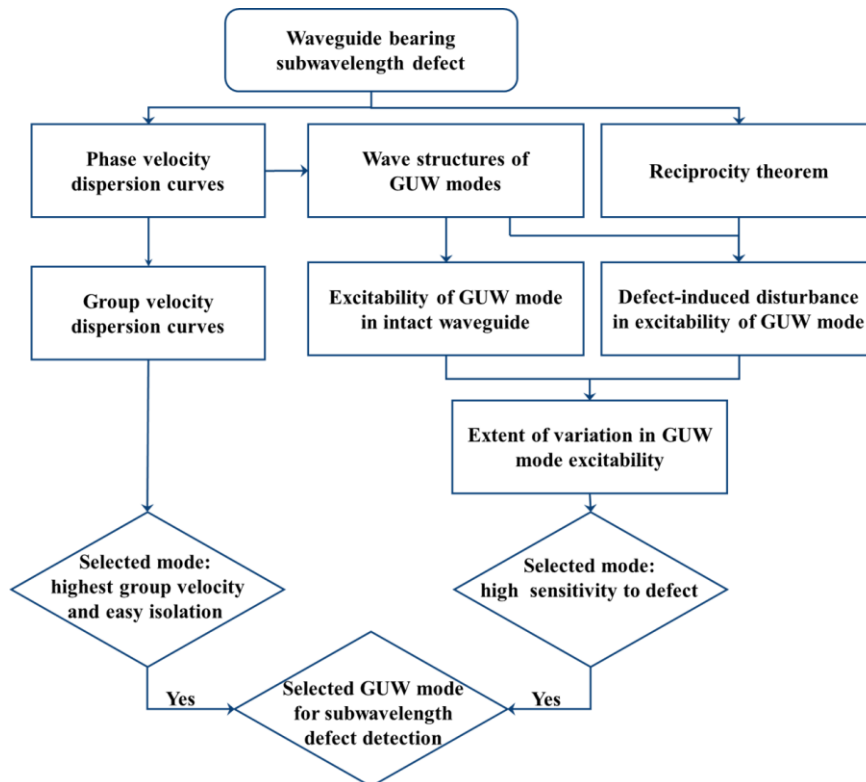
152 **2.1 Problem Description**

153 Considering that the mechanism behind the defect-induced disturbance is essentially
154 similar regardless of the locations of defects (e.g., surface or subsurface), the wave
155 excitation in a plate-like waveguide bearing a surface defect is investigated without
156 losing generality, as schematically illustrated in Fig. 1. The waves can be excited via
157 diverse fashions, and the out-of-plane loading applied on the surface of the waveguide
158 is considered in this study, which can be generated using piezoelectric transducers or
159 laser pulses. In the waveguide, the incident G UWs take the modality of Lamb waves,
160 which encompass multiple wave modes including symmetric and antisymmetric modes.
161 A defect of subwavelength size is located on the top surface of the waveguide,
162 representing a local thinning flaw which is a common concern for manufacturing
163 industries. To improve the sensitivity and to enhance the reliability of the G UW-based
164 defect detection, several key points should be addressed from both theoretical and
165 practical perspectives. Theoretically, interpretation of the excitability of each G UW
166 mode in the intact waveguide and the defect-induced disturbance in excitation of G UW
167 modes provides a basis for the selection of preferred G UW mode which features high
168 sensitivity to the defect. Practically, as multiple G UW modes co-exist in the waveguide,
169 the precise isolation and extraction of the preferably selected G UW mode is critical for
170 the precision and reliability of the quantitative evaluation of defect. To address a step-
171 to-step solution to all these issues, a framework is proposed, as illustrated in the
172 flowchart in Fig. 2. This flowchart provides an overall view of the analysis and the
173 position of each step (Section 2.2-2.4) in the whole procedure. Via the proposed
174 framework, the G UW modes with the capacity of identifying the subwavelength defect

175 are selected, which feature high sensitivity to defect and appropriate group velocities.
 176 Each key step in the flowchart and each criterion are elaborated in the following
 177 sections.



178
 179 Fig. 1 Schematic illustration of excitation of GUVs (a) in the intact region and (b) at
 180 the location of surface or subsurface defect



181
 182 Fig. 2 Framework for the selection of GUV mode featuring high sensitivity to defect
 183 and practical feasibility
 184

185 **2.2 Excitability of GUW Modes in Intact Waveguide**

186 The propagation of Lamb waves can be analytically depicted using the Rayleigh-Lamb
 187 equation, and by solving the equation via numerical methods, the phase velocity
 188 dispersion curves can be obtained. On this basis, the group velocity and the wave
 189 structure of each GUW mode can be explicitly derived. Recalling the elasto-dynamic
 190 method, a quantitative description of waves excited by the out-of-plane loading on the
 191 surface of the waveguide[30, 41], can be given as follows,

192
$$\mathbf{v}(x_1, x_2) = \sum_n a_n(x_1) \mathbf{v}_n(x_2) \propto \sum_n \frac{v_{2,n}(x_2)}{4P_{mn}} \mathbf{v}_n(x_2), \quad (1)$$

193 where $\mathbf{v}(x_1, x_2)$ is the velocity vector superposed from all the n possibly excited
 194 GUW modes, $v_{2,n}$ is the component of velocity vector in the out-of-plane loading
 195 direction for mode n . Here and hereafter, the time factor $e^{-i\omega t}$ is omitted, in which
 196 ω and t are the angular frequency and time, respectively. $a_n(x_1)$ is the amplitude.
 197 P_{mn} is the power flux of the mode n along x_1 direction, as defined in [30], and
 198 $\mathbf{v}_n(x_2)$ is the velocity vector corresponding to the P_{mn} . Provided a normalized power
 199 flux P_{mn} , the calculated value of $v_{2,n}$, a representation of mode relative excitability, at
 200 the top surface of an aluminum plate whose properties are listed in Table 1 is displayed
 201 in Fig. 3.

202
 203

Table 1 Mechanical properties of the aluminum plate

Density [kg/m ³]	Elastic modulus [GPa]	Poisson's ratio	c_L [m/s]	c_T [m/s]
2660	71.8	0.33	6324	3185

204

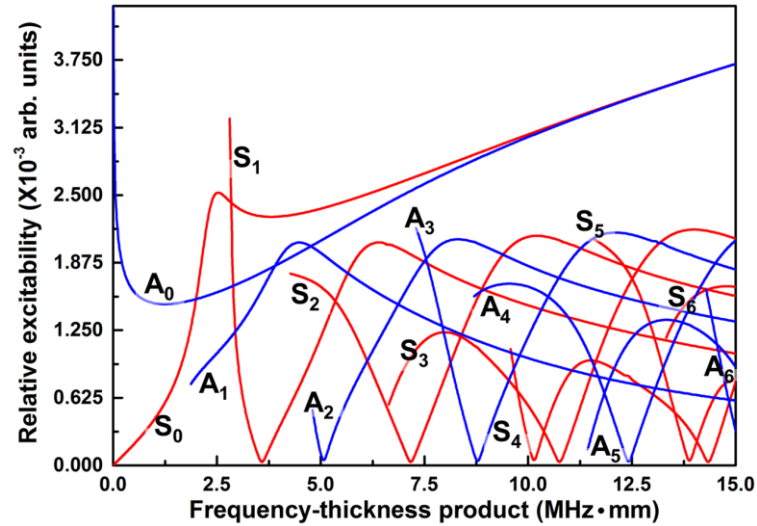
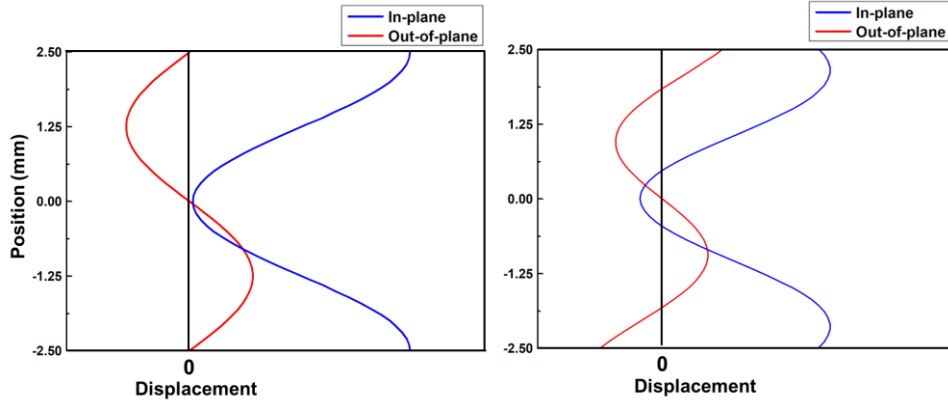


Fig. 3 Relative excitability of each Lamb mode in an intact aluminum plate

205
206
207

208 Note that, for the considered loading (out-of-plane loading on the surface), the
209 excitability of each GUV mode varies dramatically against the incident frequency, and
210 particularly, at some specific frequencies, the excitability of certain GUV modes is zero.
211 This variation arises from the changes in the wave structure of each GUV mode against
212 the incident frequency. For example, Fig. 4 representatively shows the wave structure
213 of particulate displacement for a normalized power flux at different frequencies, from
214 which it is clearly observed that at 4.5 MHz·mm, the out-of-plane displacement at the
215 surface is moderately large, while at 3.58 MHz·mm, the corresponding displacement is
216 zero. This indicates that at this specific frequency-thickness product, the out-of-plane
217 loading exerted on the waveguide surface does not perform work on the S_1 mode.
218 Therefore, the excitability of mode S_1 at 3.58 MHz·mm by the out-of-plane loading is
219 minimal.



220

221

222

223 Fig. 4 Wave structure of the S_1 mode at the frequency-thickness product of (a) 3.58

224

MHz·mm and (b) 4.5 MHz·mm in an aluminum plate

225

226 2.3 Defect-induced Disturbance in Excitability of GUW Modes

227 The defect-modulated excitation problem is schematically illustrated in Fig. 5. An

228 infinite homogeneous isotropic elastic plate measuring $2h$ in thickness bears a defect

229 with the width w and depth d which is located on the top surface of the plate. The intact

230 top and bottom surfaces are denoted as S^+ and S^- , respectively, and the surface of defect

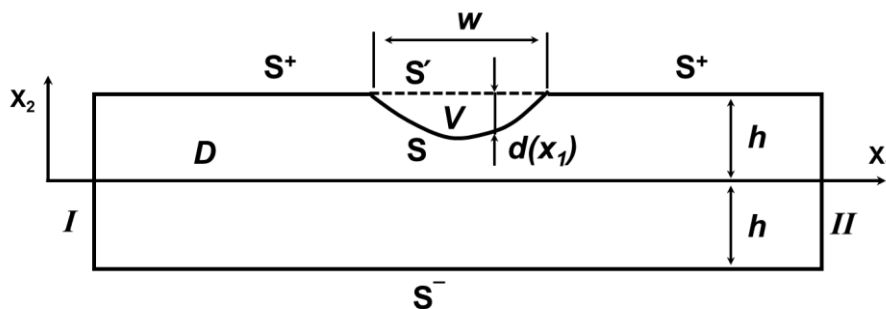
231 as S and the original intact surface at the defect site as S' . $S^+ \setminus S'$ denotes the top

232 surface when part S' is removed. The volume of defect area bounded by S and S' is

233 denoted as V and the region of an intact plate is denoted by D . The out-of-plane loading

234 in the intact case is a pressure of Q on the surface S' , and when the loading is applied

235 on the defect, a pressure of Q is exerted on the surface S .



236

Fig. 5 Schematic illustration of waveguide bearing a surface defect

237

238

239

In accordance with the reciprocal theorem, two distinct elasto-dynamic states of the

240

same body can be related via the reciprocal identity [42, 43]. For two distinct time-

241

harmonic states, labeled by superscripts A and B , the reciprocal identity for the region

242

D bounded by the surfaces $S^+ \setminus S' + S + S^- + I + II$ reads

243

$$\int_D (f_i^A u_i^B - f_i^B u_i^A) dv = \int_{S^+ \setminus S' + S + S^- + I + II} (u_i^A \sigma_{ij}^B - u_i^B \sigma_{ij}^A) \eta_j ds. \quad (2)$$

244

In the above, f_i^A and f_i^B are the body forces, u_i^A and u_i^B are the displacement

245

fields, σ_{ij}^A and σ_{ij}^B are the stress fields, η_j are the components of the outward

246

normal.

247

248

For the time-harmonic state denoted by A , we choose a Lamb wave mode of unit power

249

flux (denoted as $\mathbf{u}^{inc} = \mathbf{u}_n(x_2) e^{ik_n x_1}$) propagating from the left side to the right side, and

250

after traversing the surface defect, reflected and transmitted wave modes are generated,

251

as shown in Fig. 6. For the other state denoted by B , we choose the solution when the

252

loading is applied on the defect, generating Lamb waves of multiple modes, whose

253

displacement field can be depicted using

254

$$\mathbf{u}^B = \sum a_m \mathbf{u}_m(x_2) e^{ik_m x_1}. \quad (3)$$

255

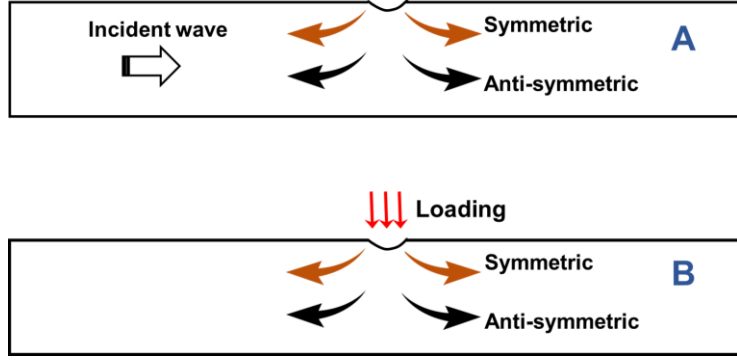
For these two chosen states, the body forces are zero, and therefore the reciprocal

256

identity reads

257

$$\int_{S^+ \setminus S' + S + S^- + I + II} (u_i^A \sigma_{ij}^B - u_i^B \sigma_{ij}^A) \eta_j ds = 0. \quad (4)$$



258

259 Fig. 6 Illustration of elasto-dynamic state A: a Lamb wave mode propagating from the
 260 left side to the right side; and state B: waves excited when the loading is applied at the
 261 location of defect
 262

263 Considering the traction free boundary conditions for both states, the integrals over
 264 surfaces $S^+ \setminus S'+S^-$ in Eq. (4) are zero, remaining only $S+I+II$ for the Eq.(4),
 265 and thus Eq. (4) can be rewritten as
 266

$$267 \int_S (u_i^A \sigma_{ij}^B) \eta_j ds + \int_{I+II} (u_i^A \sigma_{ij}^B - u_i^B \sigma_{ij}^A) \eta_j ds = 0. \quad (5)$$

268 Recalling the orthogonality between different Lamb modes, for the second term in Eq.
 269 (5), we have

$$270 \int_{I+II} (u_i^A \sigma_{ij}^B - u_i^B \sigma_{ij}^A) \eta_j ds = \int_I (u_i^A \sigma_{ij}^B - u_i^B \sigma_{ij}^A) \eta_j ds = 4a_n P_{mn} / (-i\omega). \quad (6)$$

271 It is worth noting that the defect is fairly small compared with the wavelength of
 272 probing waves, leading to a negligible reflection. According to Born approximation, the
 273 wave field in state A that encompasses incident waves, reflected waves and transmitted
 274 waves, can be approximately replaced by the incident wave fields if the reflection is
 275 small enough [44]. Therefore, after some mathematical manipulations, the first term in
 276 Eq. (6) can be rewritten as

$$277 \begin{aligned} & \int_S (u_i^A \sigma_{ij}^B) \eta_j ds \\ &= \int_S [Qu_i^A \eta_i] ds \\ &= \int_S [Qu_i^{inc} \eta_i] ds \\ &= \int_{S+S'} [Qu_i^{inc} \eta_i] ds - \int_{S'} [Qu_i^{inc} \eta_i] ds. \end{aligned} \quad (7)$$

278 Substituting Eqs.(6) and (7) into Eq. (5), one can get

$$279 \quad \frac{-i\omega}{4P_{nm}} \int_{S+S'} [Qu_i^{inc} \eta_i] ds = a_n - \frac{-i\omega}{4P_{nm}} \int_{S'} [Qu_i^{inc} \eta_i] ds. \quad (8)$$

280 Noticing that the second term on the right side of Eq. (8) is the amplitude of the wave
281 mode excited by the loading of Q on the surface S' of the intact waveguide, and thus

$$282 \quad a_n^{intact} = \frac{-i\omega}{4P_{nm}} \int_{S'} [Qu_i^{inc} \eta_i] ds. \quad (9)$$

283 Therefore the term on the left side of the Eq. (8) represents the deviation of the
284 amplitude of mode n excited in the defect scenario from that in an intact scenario. In
285 light of the Gauss's divergence theorem, the term on the left side of Eq. (8) can be
286 further defined as

$$287 \quad \frac{-i\omega}{4P_{nm}} \int_{S+S'} [Qu_i^{inc} \eta_i] ds = \frac{Q \cdot (-i\omega)}{4P_{nm}} \int_V \left(\frac{\partial u_1^{inc}}{\partial x_1} + \frac{\partial u_2^{inc}}{\partial x_2} \right) dv. \quad (10)$$

288 Recalling that the defect is fairly small compared with the wavelength of probing waves,
289 the integrand can be approximated by the integrand at the surface of the plate, and
290 therefore Eq.(10) can be rewritten as

$$291 \quad \frac{-i\omega}{4P_{nm}} \int_{S+S'} [Qu_i^{inc} \eta_i] ds = \frac{Q \cdot (-i\omega)}{4P_{nm}} \left(ik \cdot u_1^{inc} + \frac{\partial u_2^{inc}}{\partial x_2} \right) \Big|_{x_2=h} \int_{-\infty}^{+\infty} h(x_1) e^{ikx_1} dx_1. \quad (11)$$

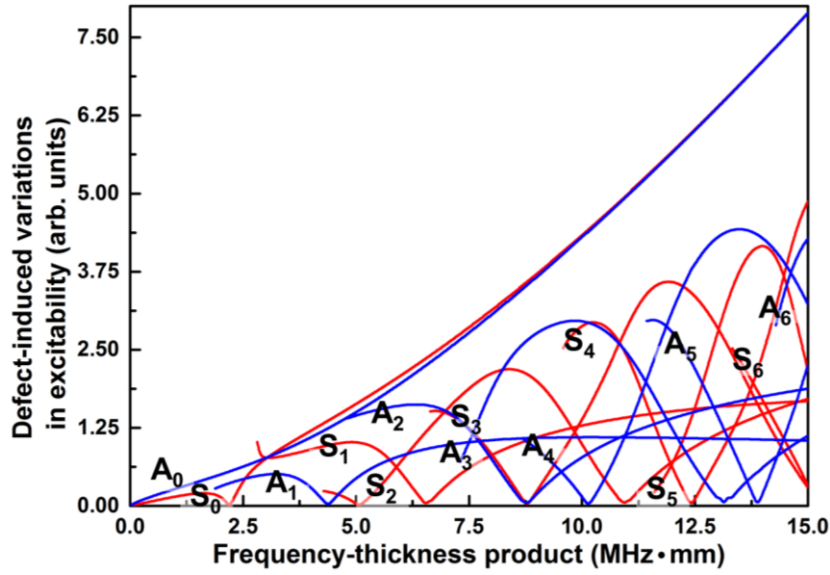
292 Substituting Eqs. (9) and (11) into Eq.(8) and denoting $\frac{Q \cdot (-i\omega)}{4P_{nm}} \left(ik \cdot u_1^{inc} + \frac{\partial u_2^{inc}}{\partial x_2} \right) \Big|_{x_2=h}$

293 as g , one has

$$294 \quad a_n - a_n^{intact} = g \cdot \int_{-\infty}^{+\infty} h(x_1) e^{ikx_1} dx_1. \quad (12)$$

295 In the above, the term g reflects the extent of the defect-induced variation in the mode
296 excitability, and the term $\int_{-\infty}^{+\infty} h(x_1) e^{ikx_1} dx_1$ represents the influence of the geometry of
297 the defect on the mode excitability. With the term g in Eq.(12), the defect-induced

298 variation in wave mode excited by the loading can be obtained, and its changes against
 299 the incident frequency is displayed in Fig. 7.



300
 301 Fig. 7 Defect-induced variations in excitability of GUV modes in an aluminum plate
 302 of 5 mm thickness against the frequency

303 2.4 Mode Selection

304 To exploit the proposed GUV-based approach, it is required that the selected GUV
 305 mode features a large extent of defect-induced variation in the excitability, guaranteeing
 306 a conspicuous change in the acquired wave signals and a high sensitivity to the defect.
 307 This feature can be represented by the ratio of defect-related changes of mode
 308 excitability to the correspondent in the intact waveguide, and it can be depicted using
 309 the following

$$310 \quad R = \frac{(a_n - a_n^{intact})}{a_n^{intact}} \propto \frac{g}{a_n^{intact}} \quad (13)$$

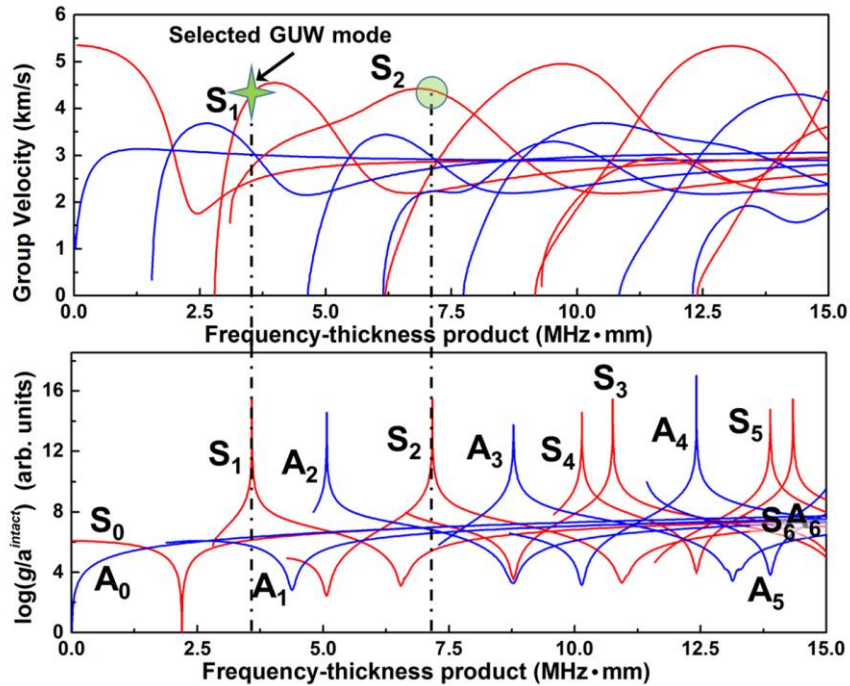
311 With Eq.(13), the trend of the ratio against incident frequency for each GUV mode can
 312 be obtained, see Fig. 8. It is clearly observed that at several specific frequencies, the
 313 ratio is drastically larger than those for other frequencies, and thus they can serve as
 314 candidate modes with practical application potential.

315

316 Considering that multiple modes can possibly be co-excited accompanying the selected
317 mode, group velocities of these candidate modes are to be scrutinized in the proposed
318 framework to facilitate the practical implementation of the approach. To make the
319 selected mode easily discernable and conveniently isolated from other modes, two
320 requirements shall be satisfied, (1) a higher and stable group velocity in the excited
321 frequency band and (2) the GUV with specific mode-frequency combination shall be
322 well separated from other possibly excited GUV modes in the time domain.

323

324 Fig. 8 displays the group velocity of each GUV mode, integrated with the ratio acquired
325 using Eq.(13). It can be clearly observed that the mode S_1 at frequency-thickness
326 product of 3.58 MHz·mm and mode S_2 at 7.16 MHz·mm features a higher group
327 velocity than other possibly excited modes, and the corresponding defect-related
328 variations in excited waves are conspicuous. From the above analysis, it can be
329 observed that these conspicuous variations arise from the wave structure features of the
330 two modes (S_1 at 3.58 MHz·mm and S_2 at 7.16 MHz·mm) and the defect-induced
331 variations in the in-plane load. Accommodating the requirements of sensitivity and
332 applicability, mode S_1 at 3.58 MHz·mm and mode S_2 at 7.16 MHz·mm offer desirable
333 selections for the GUV-based defect characterization, which enables the enhanced
334 characterization of subwavelength defects. In addition, the mode S_1 at 3.58 MHz·mm
335 features a lower incident frequency that is conducive to a larger inspection region. Thus
336 it provides a preferable choice for the defect characterization and will be used in the
337 numerical and experimental examinations. Note that the defect induces disturbance in
338 the mode excitability in a similar mechanism regardless of the location of the defect,
339 and thus the above analysis of mode selectivity and the preferred candidate modes also
340 apply for the subsurface and interior defects.



341
342
343
344
345

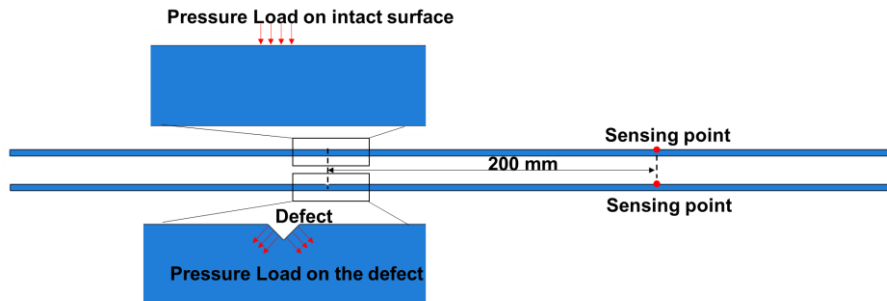
Fig. 8 Candidate GUV modes which feature easy isolation and excitability of high sensitivity to defect and: S_1 at 3.58 MHz·mm and S_2 at 7.16 MHz·mm in an aluminum plate

346 **3. Numerical Analysis Proof-of-concept**

347 **3.1 Finite Element Model Set-up**

348 For proof of concept, a time domain finite element analysis (FEA) is performed with
 349 ABAQUS®/Explicit. A two-dimensional plate measuring 5 mm in thickness and 1 m
 350 in length is constructed using a plane strain model, see Fig. 9, with key material
 351 properties listed in Table 1. The defect is modeled with a V-shape notch on the surface
 352 of the plate (width 2 mm, depth 0.5 mm). A global mesh of 0.1 mm size and a time step
 353 of 1×10^{-8} s are set to warrant the accuracy of the simulation results. In the FEA model,
 354 an out-of-plane loading (pressure load) is applied on the surface of the plate (within a
 355 circular area of 2 mm diameter) to excite the probing waves, which is consistent with
 356 the loading condition in the experiment. To outstand the defect-induced variation in
 357 excitability of GUV mode, the FEA analysis is performed for scenarios when the waves

358 are excited from the intact region and locations of defects. The in-plane displacement
359 of a sensing point on the waveguide surface with a distance of 200 mm from the loading
360 is recorded.



361

362 Fig. 9 FE model for validation

363 A one-cycle Hanning windowed toneburst with a central frequency of 0.9 MHz is first
364 used to excite GUWs from the intact region and the defect location, respectively. This
365 allows the examination of the excitability of the each GUW mode in both cases in a
366 broadband low-frequency range. On this basis, the mode-frequency combinations that
367 feature high sensitivity and high group velocity, which is predicted to be the S_1 mode
368 at 0.716 MHz as analyzed above, can be selected for further examination of effect of
369 defect on GUW mode excitation.

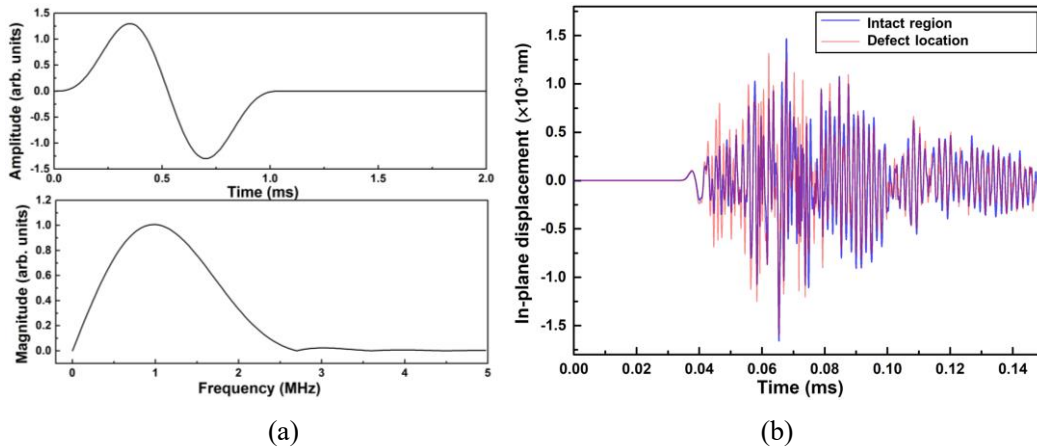
370

371 A ten-cycle Hanning windowed toneburst with the selected central frequency (predicted
372 to be 0.716 MHz) is then applied to test the GUW mode excitation in the intact region
373 and at the defect location, respectively. Results from both cases will be contrasted to
374 outstand the defect-induced variations in selected GUW modes (i.e. S_1 mode).

375 3.2 Results: Wideband Excitation

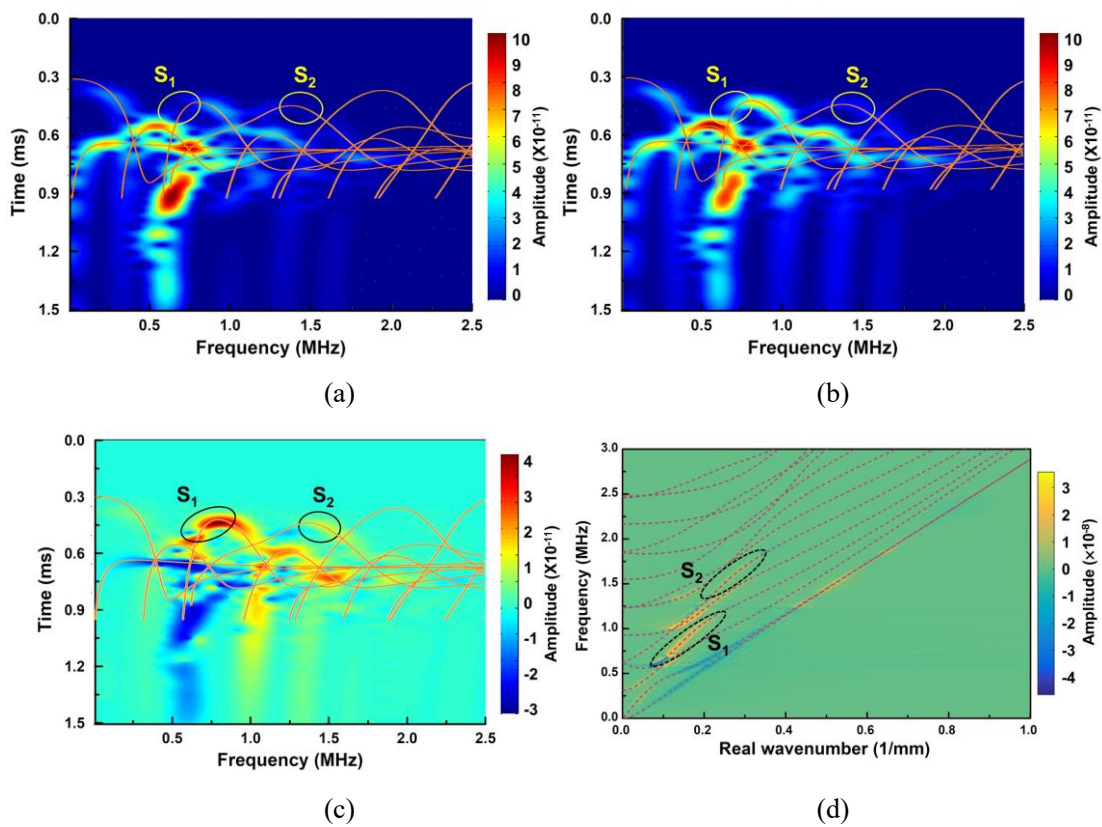
376 By way of illustration, the results obtained when the excitation transducers are on the
377 intact region and the location of a surface defect, respectively, when the one-cycle
378 toneburst (see Fig. 10(a)) is applied, are displayed in Fig. 10(b), clearly showing the

379 conspicuous defect-induced changes in the acquired signals. In order to evaluate the
380 excitability of each G UW mode, the short time Fourier transform (STFT) is performed,
381 and the spectra in the time-frequency domain is shown in Fig. 11, integrated with the
382 dispersion curves of G UW modes. The parameters of STFT (window size $10\mu\text{s}$ and
383 window gap $0.1\mu\text{s}$) are prudently chosen so that sufficient details of in time and
384 frequency domains can be retained. It is obvious that the amplitude of S_1 mode at
385 frequency of 0.716 MHz excited in the intact case is phenomenally lower than the
386 adjacent components, as highlighted by the circle in Fig. 11(a), arguing the above
387 analysis that the excitability of S_1 mode at this frequency is minimal. Compared with
388 the intact case, the S_1 mode at 0.716 MHz excited when the loading is applied on the
389 defect is dramatically increased, as displayed in Fig. 11(b). To outstand the defect-
390 induced changes in the excitation of each G UW mode, the spectrogram from the defect
391 case are subtracted from that obtained from intact case, with results shown in Fig. 11(c),
392 to observe that the defect-induced changes is drastic for S_1 mode at 0.716 MHz and
393 mode S_2 at 1.43 MHz. A two-dimensional fast Fourier transform (2D-FFT) is performed
394 on the signals acquired from a set of 200 points, and the difference between the spectra
395 from the defect case and that from the intact case is shown in Fig. 11(d), further
396 validating the above observation. This coincides well with the analytical results shown
397 in Fig. 8, corroborating the assertion in section 2 that the extent of defect-induced
398 variations in excitation of mode S_1 at 0.716 MHz is the greatest for the plate of 5 mm
399 thickness, justifying its superiority for the defect evaluation in the following analysis.



400
401
402
403

Fig. 10 (a) The toneburst used for the wideband wave excitation and its spectrum and (b) the signals acquired from the sensing point



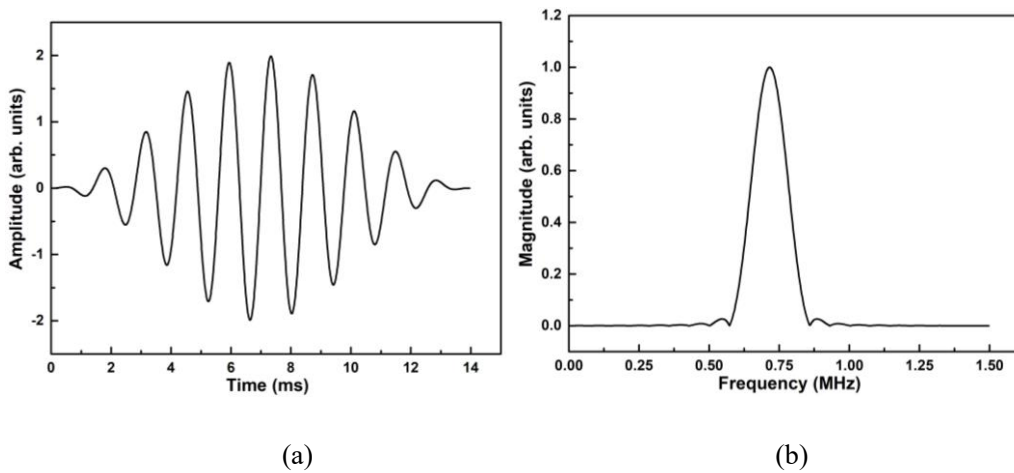
404
405
406
407

Fig. 11 The STFT spectrogram of signals acquired when waves are excited from (a) intact region and (b) a defect location; (c) the result obtained by subtracting spectrogram in (b) by that in (a); (d) the result obtained by subtracting the 2D-FFT spectrogram of signals of waves excited from a defect location by that from the intact region

414 3.3 Results: Narrowband Harmonic Excitation

415 To examine the extent of the defect-induced variation in the excitation of selected mode,

416 i.e. S_1 mode at 0.716 MHz, the ten-cycle tone burst with an identical central frequency
 417 (see Fig. 12(a)) are applied in the FEA model to excite GUWs in a narrow frequency
 418 band, as shown in Fig. 12(b). The results obtained when waves are excited from the
 419 intact region and the location of a surface defect are compared in Fig. 13(a). According
 420 to the velocity of each wave packets, it is clearly known that the first arrival
 421 wavepackets (denoted by the time window in Fig. 13(a)) are of S_1 mode, and it can be
 422 observed that in the intact case, the amplitude of S_1 mode is relatively low, while in the
 423 defect case, the corresponding amplitude is clearly increased.

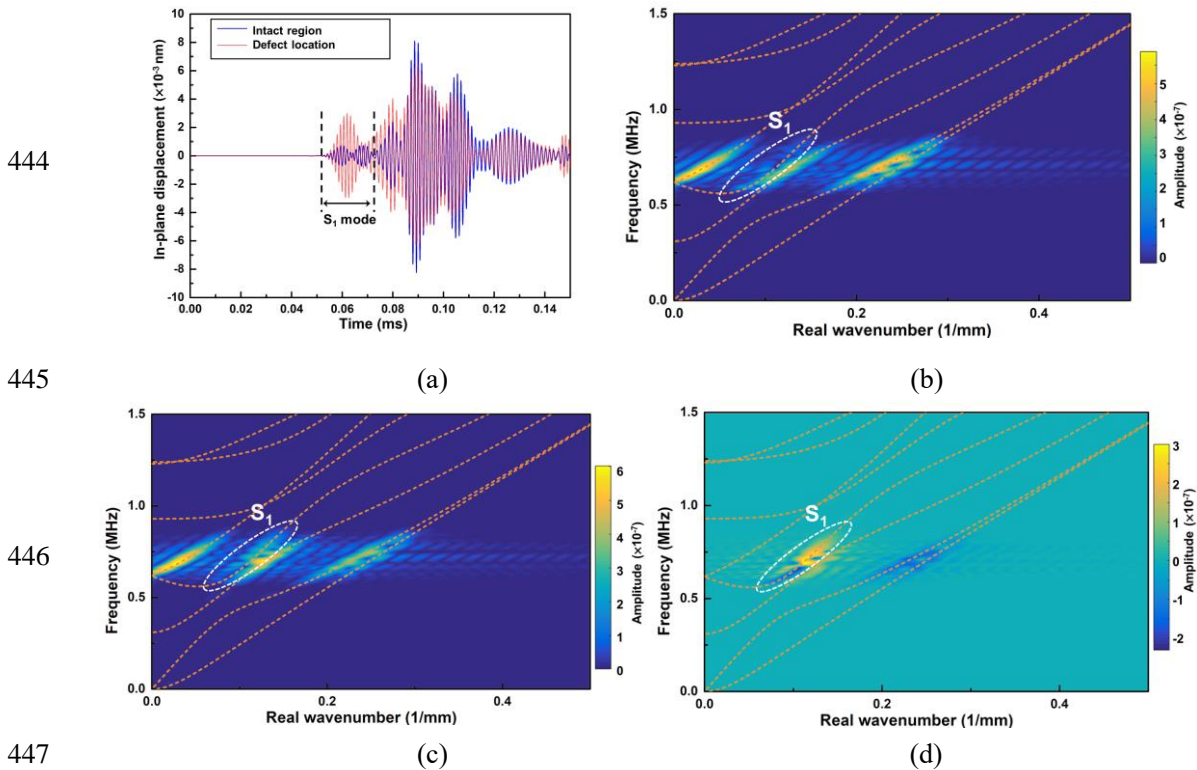


424
 425 (a) (b)
 426 Fig. 12 (a) The tone burst used for the narrowband wave excitation and (b) its
 427 spectrum
 428

429
 430 To analyze the amplitude of each GUW mode, a 2D Fourier transform is performed on
 431 the signals acquired from an array of sensing points on the surface of the waveguide,
 432 with results from the intact case and defect case shown in Fig. 13(b) and (c),
 433 respectively. The comparison clearly indicates the dramatic intensification by the defect
 434 in the excitation of S_1 mode. Subtracting the spectrogram for the intact case from that
 435 for the defect case gives the defect-induced variations in the spectral energy of each
 436 wave mode, with results shown in Fig. 13(d). The result agrees well with the theoretical
 437 analysis and the results from the wideband excitation case, validating that the
 438 excitability of selected mode features an outstanding sensitivity to the defect. The

439 highest velocity of the S_1 mode reflects its great extractability. Note that, with the
 440 narrowband harmonic excitation, the energy of selected S_1 mode at the optimal
 441 frequency can be enhanced, thus leading to a more significant difference between the
 442 signals from cases with and without damage.

443



448 Fig. 13(a) The signals acquired when waves are excited from intact region and the
 449 location of a defect; the 2D-FFT spectrogram of signals of waves excited from (b)
 450 intact region and (c) the defect location; (d) the result obtained by subtracting
 451 spectrogram in (c) by that in (b)

452 Using the theoretical analysis and the FEA, the defect-induced variations in excitation
 453 of each GUW mode by the out-of-plane loading is investigated, on which basis the
 454 candidates of mode-frequency combination are selected for practical implementation.
 455 This provides the basis for the characterization of subwavelength defects with high
 456 sensitivity and practical applicability. It is noteworthy that in conventional methods, the
 457 defect is evaluated using the changes in the amplitude of GUWs, whose measurements
 458 are prone to the contaminations from diverse noises. On the contrary, the proposed
 459

460 method can detect the defect using the changes in the waveform of GUWs using the
461 selected mode, as exhibited in Fig. 13(a), providing higher reliability and enhanced
462 accuracy.

463 **4. Experimental Validation**

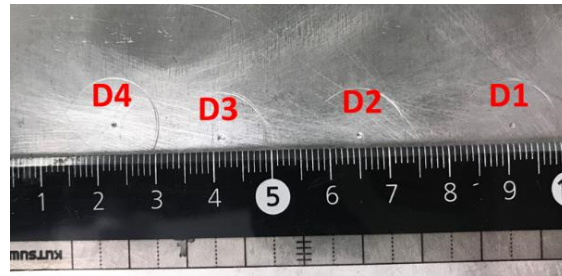
464 **4.1 Experimental Set-up**

465 An aluminum plate (Aluminum 6061-T6) measuring 5 mm in thickness whose
466 properties are listed in Table 1 is examined experimentally. Defects with different sizes
467 are produced on the surface of the plate using a drill. An illustration of the specimen
468 and defects is shown in Fig. 14(a), and the diameters of the defects D1, D2, D3 and D4
469 are 0.5 mm, 1.5 mm, 2 mm and 0.7 mm, respectively. The depths of these defects are
470 lower than 0.8mm.

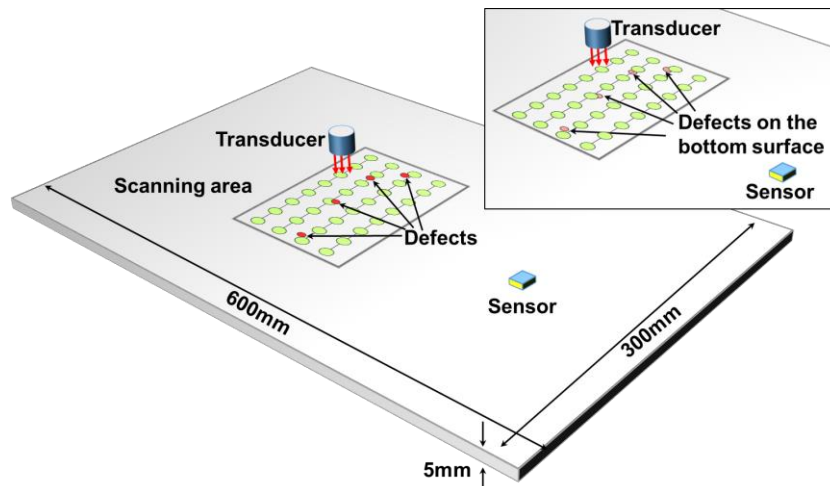
471

472 A computer controlled system (Ritec® 5000 SNAP) is used to generate excitation
473 signals, which are then fed into a piston piezoelectric transducer (diameter 2 mm) with
474 central frequency of 1 MHz, as shown in Fig. 14(b), serving as an actuator to excite
475 GUWs in the specimen. Couplant (Olympus® Glycerin) is utilized to ensure a
476 consistent coupling between the transducer and the waveguide, via which the out-of-
477 plane loading is transmitted onto the surface. A one-cycle Hanning-window modulated
478 sinusoidal toneburst is used to excite waves in the plate to examine the excitability of
479 each GUW mode in a wide frequency range. A ten-cycle Hanning-window modulated
480 sinusoidal tone burst is then used to excite waves when the transducer scans over the
481 inspected area covering the defects to investigate the defect-induced disturbance in the
482 selected GUW mode, as schematically displayed in Fig. 14(b). The scanning path is

483 denoted by the line with a distance of 2 mm between adjacent wave excitation points.
 484 A PZT wafer (2 mm x 2 mm) that measures the in-plane strain is mounted on the surface
 485 of the plate to capture the excited GUWs. To further examine the capacity of the
 486 proposed approach for the characterization of defects on the inaccessible surfaces, the
 487 ultrasonic scan with the same set-up are performed when the defects are located on the
 488 bottom surface of the plate, representing subsurface defects. Wave signals acquired
 489 from 256 measurements are averaged to suppress the measurement noises. The acquired
 490 signals are processed using the STFT to obtain the spectra.



(a)



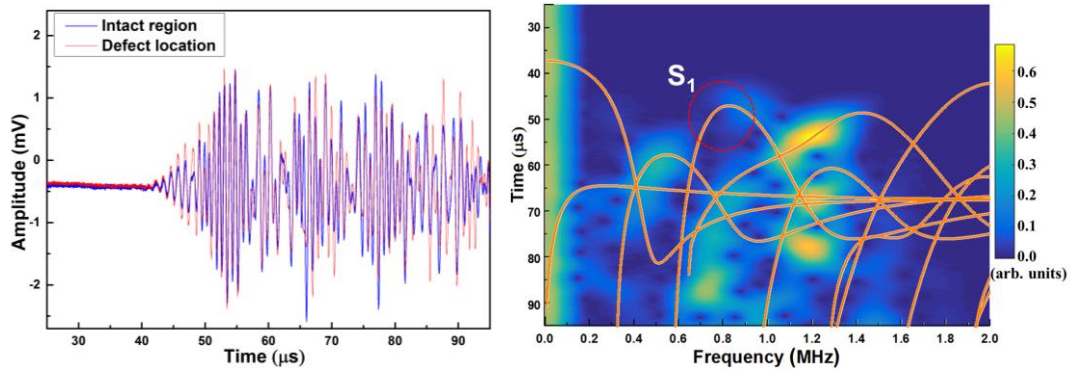
(b)

495 Fig. 14 Four defects of subwavelength size on the surface of an aluminum plate; (b)
 496 illustration of the set-up for the scanning test in which the defects and the
 497 transducer/sensor are on the top surface (inset: the defects are on the bottom surface)
 498
 499

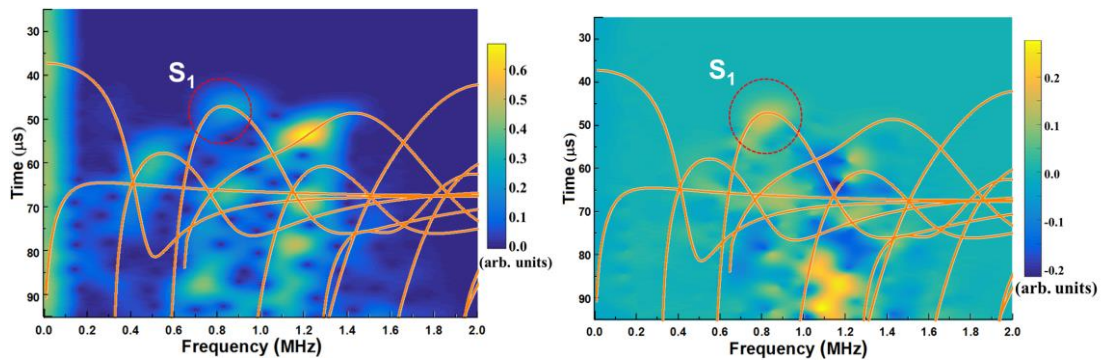
500 4.2 Results and Discussions

501 The results when a one-cycle tone burst is used are shown in Fig. 15(a), and the

502 corresponding spectra are displayed in Fig. 15(b) and (c). The S_1 mode at 0.716 MHz
 503 is observed to be barely excited in the intact region (see Fig. 15(b)) which agrees well
 504 with the theoretical analysis and FE analysis (see Fig. 11), and the amplitude of the
 505 excited S_1 mode at 0.716 MHz is dramatically increased when the wave excitation is
 506 altered by the defect, as shown in the Fig. 15 (c) and (d).



507
 508



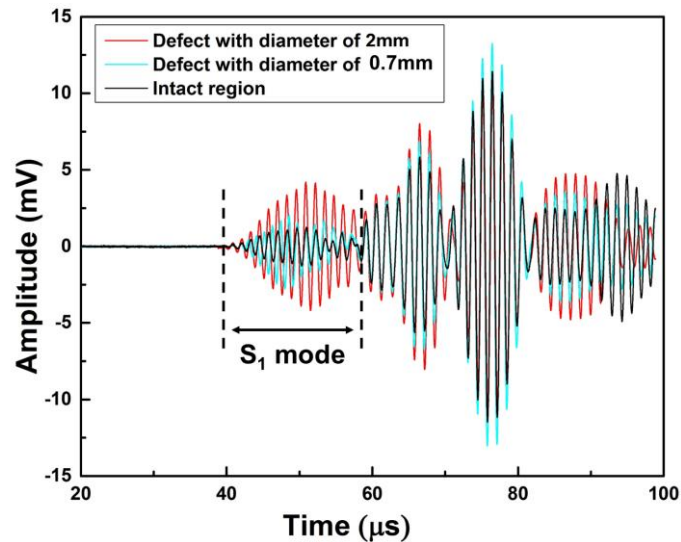
509
 510
 511

512 Fig. 15 (a) The signals acquired when the waves are excited from the intact region and
 513 the defect location; the STFT spectrogram of signals of waves excited from (b) intact
 514 region and (c) defect location; (d) the result obtained by subtracting spectrogram in
 515 (c) by that in (b)

516

517 As a representation, Fig. 16 shows the typical signals acquired when the ten-cycle tone
 518 burst of selected frequency (i.e. 0.716 MHz) is applied on the intact region and two of
 519 the defect locations (diameter 2 mm and 0.7 mm). It is clearly observed that the
 520 amplitude of the S_1 mode (see the signals in the denoted time window in Fig. 16) is
 521 increased by the defect, corroborating the above theoretical and FE investigations,
 522 verifying the optimal sensitivity of excitability of S_1 mode at $3.58 \text{ MHz}\cdot\text{mm}$ to defects.

523 More importantly, the waveforms of S_1 mode are dramatically changed due to the non-
524 uniform increasing in the components at the selected frequency (i.e. 0.716 MHz in the
525 plate of 5mm thickness) and closely adjacent frequencies. This provide the basis for the
526 accurate and reliable imaging of the defects.



527

528 Fig. 16 The signals acquired when the waves are excited from the intact region and
529 the defect location when the ten-cycle tone burst is applied

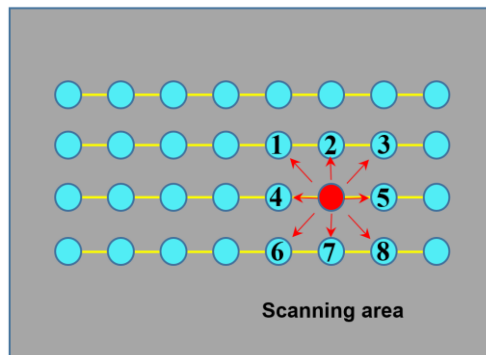
530 5. Defects Characterization and Imaging Using Damage Indices

531 From the above numerical and experimental investigations, it is observed that the defect
532 induces obvious changes in the waveforms of selected wave mode, and the waves
533 generated from spatially adjacent points in the absence of defect are highly coherent.
534 Therefore, the defects can inversely be identified and characterized by measuring the
535 de-coherence between signal waveforms of waves excited from adjacent points.
536 Inspired by the stimulus to visualize and quantify the small defects, an imaging
537 algorithm is proposed. In this algorithm, an index, based on the decorrelation between
538 signals in specific time windows (corresponding to the S_1 mode) and generated from
539 adjacent excitations, is developed to reflect the extent of defect-induced variations,
540 which can be depicted as follows

541
$$DI_n^i = 1 - \max_{\tau} \frac{\int_{t_1}^{t_2} X_n(t) \cdot Y_i(t + \tau) dt}{\sqrt{\int_{t_1}^{t_2} X_n(t)^2 dt \cdot \int_{t_1}^{t_2} Y_i(t + \tau)^2 dt}}. \quad (14)$$

542 In the above, $X_n(t)$ is the signal of waves generated from the n^{th} exciting point, and
 543 $Y_i(t + \tau)$ is the signal of waves generated from the i^{th} adjacent point of the n^{th} exciting
 544 point, see Fig. 17. t_1 and t_2 denote the beginning and end of the time window for the
 545 wave packets of S₁ mode, respectively. Considering the difference in the propagation
 546 time between waves excited from the exciting point and its adjacent points, a time delay
 547 τ is applied to accommodate this difference. The indices DI_n^i represent normalized
 548 coefficients indicating the level of de-correlation in the signal waveforms of waves
 549 generated from the exciting point and the points in its proximity. Except the points at
 550 the boundary of the scanning area, a total of 8 adjacent points are used for the
 551 calculation of DI_n^i ($i=1, 2, \dots, 8$) for each exciting point, and the mean value of these
 552 DI_n^i is defined as the damage index for the n^{th} exciting point, which can be obtained
 553 using

554
$$\overline{DI}_n = \frac{\sum_i DI_n^i}{8} \quad (15)$$



555
 556 Fig. 17 Illustration of the imaging algorithm and the calculation of damage index.
 557

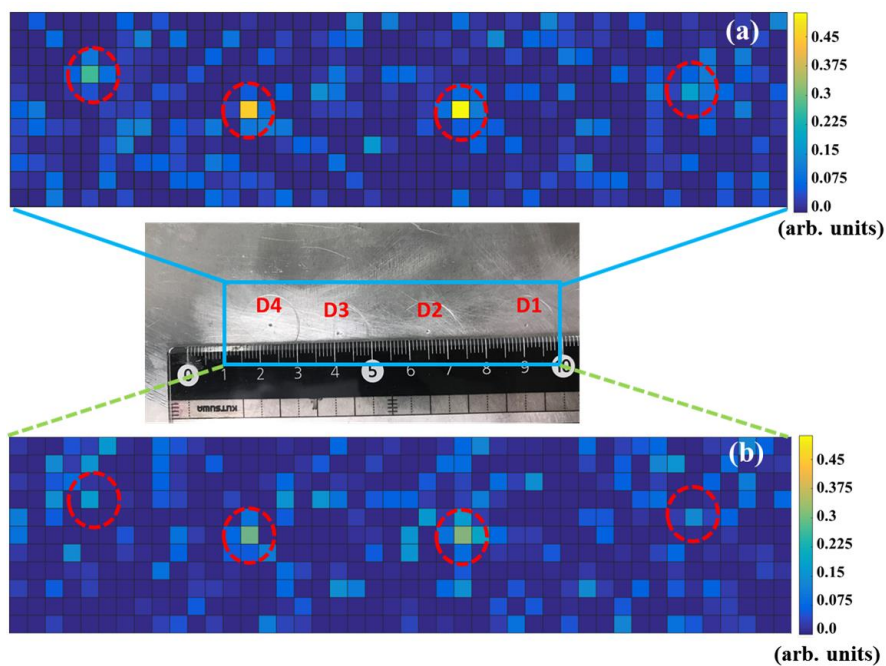
558 In accordance with Eq.(15), the image of the entire scanned area can be constructed,

559 and the points with outstandingly high values of \overline{DI} indicate the locations of defects,
560 which can also reflect the severity of the defect. Figure 18(a) displays the imaging
561 results obtained using the narrowband excitation when the transducer scans over the
562 top surface of the plate. It can be observed that the defect with a diameter not less than
563 0.7 mm (i.e. D2, D3 and D4) can be clearly identified, while the defect D1 with an
564 approximated size of 0.5 mm can be barely discerned. The imaging results obtained
565 when the defects are located on the bottom surface of the plate are shown in Fig. 18(b),
566 to observe that the defects D2 and D3 can be detected. Nevertheless, the defects D1 and
567 D4 cannot be discerned due to the fact that the disturbance of mode excitability induced
568 by the defect on the bottom surface of the plate is relatively weak, making it prone to
569 the contamination of measurement noises.

570

571 The experimental results validate the enhanced sensitivity of the proposed approach
572 towards the characterization of subwavelength defects using scanning GUWs.
573 Compared with conventional methods which evaluate the subtle changes in the
574 amplitude or phase of specific modes (e.g. C-scan, energy enhancement methods) [33,
575 45], the proposed approach can identify the defect of a subwavelength size by
576 evaluating the variation in the waveform of acquired signals. This endows the proposed
577 approach a higher immunity to measurement uncertainty caused by diverse factors (e.g.
578 couplant), thereby rendering an improved reliability. The proposed scanning GUW-
579 based approach can also be adopted for the damage characterization in scenarios
580 including defect in a thin plate, near-surface defects and defect in composite laminates,
581 showing superior detectability than the conventional methods. In addition, all the
582 signals for imaging are obtained in the current status without the need to acquire any
583 prior knowledge, which features a baseline-free fashion, further facilitating the

584 applicability of the proposed damage indices for characterization of defects. To further
585 improve the sensitivity and the spatial resolution, different techniques for the wave
586 excitation and acquisition (e.g. laser ultrasonic technique) can be exploited. For
587 example, with the exploitation of acousto-optic modulator [35, 46], laser-generated
588 GUWs of optimal mode can be selectively excited with a concentrated loading and thus
589 the uncertainty related with diverse practical factors (e.g. couplant) can be eliminated.
590 It is worth noting that the proposed method is applicable for various defects (e.g. pitting
591 damage and shallow corrosion) regardless of their shapes and types.



592
593 Fig. 18 The imaging results of damage index (a) when defects are located on the top
594 surface and (b) when defects are located on the bottom surface.

595 6. Conclusions

596 Targeting enhancing the sensitivity of the scanning GUV-based method, a framework
597 is constructed by making use of the effect of defect on the excitability of GUV modes,
598 on which basis the GUV mode with optimal sensitivity and high applicability can be
599 selected, enabling the characterization of subwavelength defect. In this framework, the

600 excitability of each GUW mode is analyzed, and the effect of defect on the excitability
601 is analytically investigated using the reciprocity theorem and the Born approximation.
602 In conjunction with the examination of group velocity of selected candidate modes, the
603 mode exhibiting high sensitivity and practical applicability is selected (i.e. mode S1 at
604 3.58 MHz·mm). Both numerical and experimental validations are performed, in which
605 the surface and subsurface defects of subwavelength scales are identified using the
606 modally selective scanning GUWs and visualized using an imaging algorithm. The
607 results presented here clearly demonstrate the capability of the proposed approach to
608 characterize the defect of subwavelength size. This approach advances the scanning
609 GUW-based methods to a highly sensitive and practically applicable modality with the
610 potential to provide sensitivity to previously undetectable small defects.

611 **Acknowledgments**

612 The work was supported by a General Project (No. 51875492) and a Key Project (No.
613 51635008) received from the National Natural Science Foundation of China. Z Su
614 acknowledges the support from the Hong Kong Research Grants Council via General
615 Research Funds (Nos. 15204419 and 15212417).

616 **References**

- 617 [1] E. Jasiūnienė, R. Raišutis, R. Šlitteris, A. Voleišis, and M. Jakas, "Ultrasonic NDT of wind
618 turbine blades using contact pulse-echo immersion testing with moving water container,"
619 *Ultragarsas" Ultrasound"*, vol. 63, no. 3, pp. 28-32, 2008.
- 620 [2] W. Harizi, S. Chaki, G. Bourse, and M. Ourak, "Mechanical damage characterization of glass
621 fiber-reinforced polymer laminates by ultrasonic maps," *Composites Part B: Engineering*, vol.
622 70, pp. 131-137, 2015.
- 623 [3] R. Růžek, R. Lohonka, and J. Jironč, "Ultrasonic C-Scan and shearography NDI techniques
624 evaluation of impact defects identification," *NDT & E International*, vol. 39, no. 2, pp. 132-142,
625 2006.

- 626 [4] T. Hayashi, M. Murase, and M. N. Salim, "Rapid thickness measurements using guided waves
627 from a scanning laser source," *The Journal of the Acoustical Society of America*, vol. 126, no.
628 3, pp. 1101-1106, 2009.
- 629 [5] S. Yashiro, J. Takatsubo, H. Miyauchi, and N. Toyama, "A novel technique for visualizing
630 ultrasonic waves in general solid media by pulsed laser scan," *NDT & E International*, vol. 41,
631 no. 2, pp. 137-144, 2008.
- 632 [6] L. Mallet, B. Lee, W. Staszewski, and F. Scarpa, "Structural health monitoring using scanning
633 laser vibrometry: II. Lamb waves for damage detection," *Smart Materials and Structures*, vol.
634 13, no. 2, p. 261, 2004.
- 635 [7] K. S. Tan, N. Guo, B. S. Wong, and C. G. Tui, "Comparison of Lamb waves and pulse echo in
636 detection of near-surface defects in laminate plates," *NDT & E International*, vol. 28, no. 4, pp.
637 215-223, 1995.
- 638 [8] J. Dong, B. Kim, A. Locquet, P. McKeon, N. Declercq, and D. Citrin, "Nondestructive
639 evaluation of forced delamination in glass fiber-reinforced composites by terahertz and
640 ultrasonic waves," *Composites Part B: Engineering*, vol. 79, pp. 667-675, 2015.
- 641 [9] J. Rao, A. Saini, J. Yang, M. Ratassepp, and Z. Fan, "Ultrasonic imaging of irregularly shaped
642 notches based on elastic reverse time migration," *NDT & E International*, vol. 107, p. 102135,
643 2019.
- 644 [10] P. Ray, X. Yu, Z. Fan, B. Srinivasan, and P. Rajagopal, "Fiber bragg grating based detection of
645 part-thickness cracks in bent composite laminates using feature-guided waves," *Smart Materials
646 and Structures*, vol. 28, no. 8, p. 085026, 2019.
- 647 [11] M. Yeasin Bhuiyan, Y. Shen, and V. Giurgiutiu, "Interaction of Lamb waves with rivet hole
648 cracks from multiple directions," *Proceedings of the Institution of Mechanical Engineers, Part
649 C: Journal of Mechanical Engineering Science*, vol. 231, no. 16, pp. 2974-2987, 2017.
- 650 [12] C. Peng, L. Bai, J. Zhang, and B. W. Drinkwater, "The sizing of small surface-breaking fatigue
651 cracks using ultrasonic arrays," *NDT & E International*, vol. 99, pp. 64-71, 2018.
- 652 [13] B. Masserey and P. Fromme, "In-situ monitoring of fatigue crack growth using high frequency
653 guided waves," *NDT & E International*, vol. 71, pp. 1-7, 2015.
- 654 [14] P. Fromme, M. Lowe, P. Cawley, and P. Wilcox, "On the sensitivity of corrosion and fatigue
655 damage detection using guided ultrasonic waves," in *IEEE Ultrasonics Symposium, 2004*, 2004,
656 vol. 2: IEEE, pp. 1203-1206.
- 657 [15] K. Wang, M. Liu, Z. Su, S. Yuan, and Z. Fan, "Analytical insight into "breathing" crack-induced
658 acoustic nonlinearity with an application to quantitative evaluation of contact cracks,"
659 *Ultrasonics*, vol. 88, pp. 157-167, 2018.
- 660 [16] K. Wang, Y. Li, Z. Su, R. Guan, Y. Lu, and S. Yuan, "Nonlinear aspects of "breathing" crack-
661 disturbed plate waves: 3-D analytical modeling with experimental validation," *International
662 Journal of Mechanical Sciences*, vol. 159, pp. 140-150, 2019.
- 663 [17] K. H. Matlack, J.-Y. Kim, L. J. Jacobs, and J. Qu, "Review of second harmonic generation
664 measurement techniques for material state determination in metals," *Journal of Nondestructive
665 Evaluation*, vol. 34, no. 1, p. 273, 2015.
- 666 [18] Y. Shen, J. Wang, and W. Xu, "Nonlinear features of guided wave scattering from rivet hole
667 nucleated fatigue cracks considering the rough contact surface condition," *Smart Materials and
668 Structures*, vol. 27, no. 10, p. 105044, 2018.
- 669 [19] Y. Shen, M. Cen, and W. Xu, "Scanning laser vibrometry imaging of fatigue cracks via

- 670 nonlinear ultrasonic guided wave scattering and mode conversion," in *Health Monitoring of*
671 *Structural and Biological Systems XIII*, 2019, vol. 10972: International Society for Optics and
672 Photonics, p. 109721I.
- 673 [20] M. Sun, Y. Xiang, M. Deng, J. Xu, and F.-Z. Xuan, "Scanning non-collinear wave mixing for
674 nonlinear ultrasonic detection and localization of plasticity," *NDT & E International*, vol. 93,
675 pp. 1-6, 2018.
- 676 [21] P. Liu, H. Sohn, T. Kundu, and S. Yang, "Noncontact detection of fatigue cracks by laser
677 nonlinear wave modulation spectroscopy (LNWMS)," *NDT & E International*, vol. 66, pp. 106-
678 116, 2014.
- 679 [22] J. Cheng, J. N. Potter, and B. W. Drinkwater, "The parallel-sequential field subtraction technique
680 for coherent nonlinear ultrasonic imaging," *Smart Materials and Structures*, vol. 27, no. 6, p.
681 065002, 2018.
- 682 [23] K. Wang and Z. Su, "Analytical modeling of contact acoustic nonlinearity of guided waves
683 and its application to evaluating severity of fatigue damage," in *Health Monitoring of Structural*
684 *and Biological Systems 2016*, 2016, vol. 9805: International Society for Optics and Photonics,
685 p. 98050L.
- 686 [24] K. Wang, W. Cao, M. Liu, Y. Li, P. Zhou, and Z. Su, "Advancing elastic wave imaging using
687 thermal susceptibility of acoustic nonlinearity," *International Journal of Mechanical Sciences*,
688 vol. 175, p. 105509, 2020.
- 689 [25] S. Liu, A. J. Croxford, S. A. Neild, and Z. Zhou, "Effects of experimental variables on the
690 nonlinear harmonic generation technique," *IEEE transactions on ultrasonics, ferroelectrics, and*
691 *frequency control*, vol. 58, no. 7, pp. 1442-1451, 2011.
- 692 [26] S. Roy, K. Lonkar, V. Janapati, and F.-K. Chang, "A novel physics-based temperature
693 compensation model for structural health monitoring using ultrasonic guided waves," *Structural*
694 *Health Monitoring*, vol. 13, no. 3, pp. 321-342, 2014.
- 695 [27] K.-Y. Jhang, C. J. Lissenden, I. Solodov, Y. Ohara, and V. Gusev, "Measurement of Nonlinear
696 Ultrasonic Characteristics," ed: Springer.
- 697 [28] P. Wilcox, "Modeling the excitation of Lamb and SH waves by point and line sources," in *AIP*
698 *Conference Proceedings*, 2004, vol. 700, no. 1: American Institute of Physics, pp. 206-213.
- 699 [29] Y. Shen and V. Giurgiutiu, "Excitability of guided waves in composites with PWAS
700 transducers," in *AIP Conference Proceedings*, 2015, vol. 1650, no. 1: American Institute of
701 Physics, pp. 658-667.
- 702 [30] J. L. Rose, *Ultrasonic guided waves in solid media*. New York: Cambridge University Press,
703 2014.
- 704 [31] L. Satyarnarayan, J. Chandrasekaran, B. Maxfield, and K. Balasubramaniam, "Circumferential
705 higher order guided wave modes for the detection and sizing of cracks and pinholes in pipe
706 support regions," *NDT & E International*, vol. 41, no. 1, pp. 32-43, 2008.
- 707 [32] D. Ratnam, K. Balasubramaniam, and B. W. Maxfield, "Generation and detection of higher-
708 order mode clusters of guided waves (HOMC-GW) using meander-coil EMATs," *IEEE*
709 *transactions on ultrasonics, ferroelectrics, and frequency control*, vol. 59, no. 4, pp. 727-737,
710 2012.
- 711 [33] P. Khalili and P. Cawley, "The choice of ultrasonic inspection method for the detection of
712 corrosion at inaccessible locations," *NDT & E International*, vol. 99, pp. 80-92, 2018.
- 713 [34] P. Khalili and P. Cawley, "Excitation of single-mode Lamb waves at high-frequency-thickness

- 714 products," *IEEE transactions on ultrasonics, ferroelectrics, and frequency control*, vol. 63, no.
715 2, pp. 303-312, 2015.
- 716 [35] R. Pierce, C. Ume, and J. Jarzynski, "Temporal modulation of a laser source for the generation
717 of ultrasonic waves," *Ultrasonics*, vol. 33, no. 2, pp. 133-137, 1995.
- 718 [36] Y. Sohn and S. Krishnaswamy, "A near-field scanning laser source technique and a
719 microcantilever ultrasound receiver for detection of surface-breaking defects," *Measurement
720 Science and Technology*, vol. 17, no. 4, p. 809, 2006.
- 721 [37] A. Clough and R. Edwards, "Characterisation of hidden defects using the near-field ultrasonic
722 enhancement of Lamb waves," *Ultrasonics*, vol. 59, pp. 64-71, 2015.
- 723 [38] A. Clough and R. Edwards, "Scanning laser source Lamb wave enhancements for defect
724 characterisation," *NDT & E International*, vol. 62, pp. 99-105, 2014.
- 725 [39] S. Dixon, B. Cann, D. L. Carroll, Y. Fan, and R. S. Edwards, "Non-linear enhancement of laser
726 generated ultrasonic Rayleigh waves by cracks," *Nondestructive Testing and Evaluation*, vol.
727 23, no. 1, pp. 25-34, 2008.
- 728 [40] T. Hayashi and M. Fukuyama, "Vibration energy analysis of a plate for defect imaging with a
729 scanning laser source technique," *The Journal of the Acoustical Society of America*, vol. 140,
730 no. 4, pp. 2427-2436, 2016.
- 731 [41] B. A. Auld, *Acoustic fields and waves in solids*. Wiley, 1973.
- 732 [42] L. W. Schmerr, *Fundamentals of ultrasonic nondestructive evaluation*. Springer, 2016.
- 733 [43] J. D. Achenbach and Y. Xu, "Wave motion in an isotropic elastic layer generated by a time-
734 harmonic point load of arbitrary direction," *The Journal of the Acoustical Society of America*,
735 vol. 106, no. 1, pp. 83-90, 1999.
- 736 [44] Y. Da, G. Dong, B. Wang, D. Liu, and Z. Qian, "A novel approach to surface defect detection,"
737 *International Journal of Engineering Science*, vol. 133, pp. 181-195, 2018.
- 738 [45] Z. Su and L. Ye, "Lamb Wave Propagation-based Damage Identification for Quasi-isotropic
739 CF/EP Composite Laminates Using Artificial Neural Algorithm: Part II - Implementation and
740 Validation," *Journal of Intelligent Material Systems and Structures*, vol. 16, no. 2, pp. 113-125,
741 2005.
- 742 [46] S. Mezil, N. Chigarev, V. Tournat, and V. Gusev, "Two dimensional nonlinear frequency-mixing
743 photo-acoustic imaging of a crack and observation of crack phantoms," *Journal of Applied
744 Physics*, vol. 114, no. 17, p. 174901, 2013.
- 745